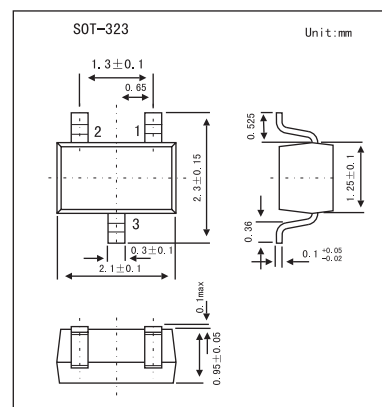


High-speed diode

BAL99W

■ Features

- Very small plastic SMD envelope
- High switching speed: max. 4 ns
- Continuous reverse voltage: max. 75 V
- Repetitive peak reverse voltage: max. 85 V
- Repetitive peak forward current: max. 500 mA.

■ Absolute Maximum Ratings $T_a = 25^\circ\text{C}$

Parameter	Symbol	Conditions	Min	Max	Unit
repetitive peak reverse voltage	V_{RRM}			85	V
continuous reverse voltage	V_R			75	V
continuous forward current	I_F			150	mA
repetitive peak forward current	I_{FRM}			500	mA
non-repetitive peak forward current	I_{FSM}	square wave; $T_j = 25^\circ\text{C}$ prior to surge; $t = 1\ \mu\text{s}$ $t = 1\ \text{ms}$ $t = 1\ \text{s}$		4 1 0.5	A
total power dissipation	P_{tot}	$T_{a\ mb} = 25^\circ\text{C}$		200	mW
Storage temperature range	T_{stg}		-65	+150	$^\circ\text{C}$
Junction temperature	T_j			150	$^\circ\text{C}$
thermal resistance from junction to tie-point	$R_{th\ j-t\ p}$			300	K/W
thermal resistance from junction to ambient	$R_{th\ j-a}$			625	K/W

BAL99W■ Electrical Characteristics $T_a = 25^\circ\text{C}$

Parameter	Symbol	Test Conditions	Max	Unit
Forward voltage	V_F	$I_F = 1\text{ mA}$	715	mV
		$I_F = 10\text{ mA}$	855	
		$I_F = 50\text{ mA}$	1	V
		$I_F = 150\text{ mA}$	1.25	
Reverse current	I_R	$V_R = 25\text{ V}$	30	nA
		$V_R = 75\text{ V}$	1	$\mu\text{ A}$
		$V_R = 25\text{ V}, T_j = 150^\circ\text{C}$	30	$\mu\text{ A}$
		$V_R = 25\text{ V}, T_j = 150^\circ\text{C}$	50	$\mu\text{ A}$
Diode capacitance	C_d	$f = 1.0\text{ MHz}, V_R = 0$	1.5	pF
Reverse recovery time	t_{rr}	when switched from $I_F = 10\text{ mA}$ to $I_R = 10\text{ mA}$; $R_L = 100\ \Omega$; measured at $I_R = 1\text{ mA}$	4	ns
Forward recovery voltage	V_{fr}	when switched from $I_F = 10\text{ mA}$; $t_r = 20\text{ ns}$	1.75	V

■ Marking

Marking	JF
---------	----